AMENDMENTS TO THE CLAIMS

The following listing of claims will replace all prior versions and listings of claims in the application.

LISTING OF CLAIMS

1. (Currently Amended) A negative resist composition comprising at least an alkalisoluble resin, a cross-linking agent which is cross-linked with the alkali-soluble resin by the action of an acid, an acidic compound, and an onium salt as a photoacid generator, in which the anion component of the onium salt is at least a sulfonate having a polycyclic structure,

wherein the cross-linking agent is a glycoluril cross-linking agent,

wherein the acidic component is at least one selected from a group consisting of phenylsulfonic acid, salicylic acid, phosphonic acid, phenylphosphonic acid, benzoic acid, and valeric acid,

wherein the anion component of the onium salt is a sulfonate represented by the following general formula (1)

and wherein the cation component of the onium salt is an iodonium salt.

2. (Cancelled)

3.	(Cancelled)
4.	(Cancelled)
5.	(Cancelled)
resist compo	(Currently Amended) A method for forming a resist pattern comprising forming at least a photoresist layer on a substrate using the negative esition according to any one of claims 1 to 5 claim 1, and forming the coresist pattern by applying exposure and development processes to the ayer.

(New) The negative resist composition according to claim 1, wherein the

(Cancelled)

cross-linking agent is tetrabutoxymethyl-glycoluril.

7.

8.